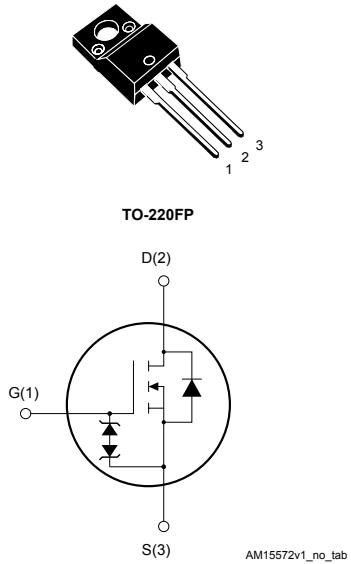


### N-channel 600 V, 1.2 Ω typ., 5 A SuperMESH Power MOSFET in a TO-220FP package

#### Features



Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>
STP5NK60ZFP	600 V	1.6 Ω	5 A

- 100% avalanche tested
- Gate charge minimized
- Very low intrinsic capacitance
- Zener-protected

#### Applications

- Switching applications

#### Description

This high-voltage device is a Zener-protected N-channel Power MOSFET developed using the SuperMESH technology by STMicroelectronics, an optimization of the well-established PowerMESH. In addition to a significant reduction in on-resistance, this device is designed to ensure a high level of dv/dt capability for the most demanding applications.



#### Product status link

[STP5NK60ZFP](#)

#### Product summary

Order code	STP5NK60ZFP
Marking	P5NK60ZFP
Package	TO-220FP
Packing	Tube

## 1 Electrical ratings

**Table 1. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage	600	V
$V_{GS}$	Gate-source voltage	$\pm 30$	V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	5	A
	Drain current (continuous) at $T_C = 100^\circ\text{C}$	3.16	
$I_{DM}^{(2)}$	Drain current (pulsed)	20	A
$P_{TOT}$	Total power dissipation at $T_C = 25^\circ\text{C}$	25	W
ESD	Gate-source, human body model ( $R = 1.5 \text{ k}\Omega$ , $C = 100 \text{ pF}$ )	3	kV
$V_{ISO}$	Insulation withstand voltage (RMS) from all three leads to external heat sink ( $t = 1 \text{ s}$ , $T_C = 25^\circ\text{C}$ )	2.5	kV
$dv/dt^{(3)}$	Peak diode recovery voltage slope	4.5	V/ns
$T_{stg}$	Storage temperature range	-55 to 150	$^\circ\text{C}$
$T_J$	Operating junction temperature range		$^\circ\text{C}$

1. Pulse width is limited by safe operating area.
2. Pulse width limited by safe operating area.
3.  $I_{SD} \leq 5 \text{ A}$ ,  $di/dt \leq 200 \text{ A}/\mu\text{s}$ ,  $V_{DS} \text{ (peak)} \leq V_{(BR)DSS}$ ,  $V_{DD} = 80\% V_{(BR)DSS}$ ,  $V_{DD} = 400 \text{ V}$ .

**Table 2. Thermal data**

Symbol	Parameter	Value	Unit
$R_{thJC}$	Thermal resistance, junction-to-case	5	$^\circ\text{C}/\text{W}$
$R_{thJA}$	Thermal resistance, junction-to-ambient	62.5	$^\circ\text{C}/\text{W}$

**Table 3. Avalanche characteristics**

Symbol	Parameter	Value	Unit
$I_{AR}$	Avalanche current, repetitive or not repetitive (pulse width is limited by $T_J$ max.)	5	A
$E_{AS}$	Single pulse avalanche energy (starting $T_J = 25^\circ\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50 \text{ V}$ )	220	mJ

## 2 Electrical characteristics

$T_C = 25^\circ\text{C}$  unless otherwise specified.

**Table 4. On/off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}$	Drain-source breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0 \text{ V}$	600			V
$I_{\text{DSS}}$	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}$			1	$\mu\text{A}$
		$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}, T_C = 125^\circ\text{C}$ <sup>(1)</sup>			50	
$I_{\text{GSS}}$	Gate body leakage current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			$\pm 10$	$\mu\text{A}$
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 50 \mu\text{A}$	3.00	3.75	4.50	V
$R_{\text{DS(on)}}$	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 2.5 \text{ A}$		1.2	1.6	$\Omega$

1. Specified by design, not tested in production.

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{\text{iss}}$	Input capacitance	$V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}, V_{GS} = 0 \text{ V}$	-	690		pF
$C_{\text{oss}}$	Output capacitance		-	90		pF
$C_{\text{rss}}$	Reverse transfer capacitance		-	20		pF
$C_{\text{oss eq.}}^{(1)}$	Equivalent output capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 0 \text{ to } 480 \text{ V}$	-	40		pF
$Q_g$	Total gate charge	$V_{DD} = 400 \text{ V}, I_D = 5 \text{ A}, V_{GS} = 0 \text{ to } 10 \text{ V}$ (see Figure 14. Test circuit for gate charge behavior)	-	26	34 <sup>(2)</sup>	nC
$Q_{gs}$	Gate-source charge		-	6		nC
$Q_{gd}$	Gate-drain charge		-	14		nC

1.  $C_{\text{oss eq.}}$  is defined as the constant equivalent capacitance giving the same charging time as  $C_{\text{oss}}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ .

2. Specified by design, not tested in production.

**Table 6. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(\text{on})}$	Turn-on delay time	$V_{DD} = 300 \text{ V}, I_D = 2.5 \text{ A}, R_G = 4.7 \Omega,$ $V_{GS} = 10 \text{ V}$ (see Figure 13. Test circuit for resistive load switching times and Figure 18. Switching time waveform)	-	16	-	ns
$t_r$	Rise time		-	25	-	ns
$t_{d(\text{off})}$	Turn-off delay time		-	36	-	ns
$t_f$	Fall time	$V_{DD} = 480 \text{ V}, I_D = 5 \text{ A}, R_G = 4.7 \Omega,$ $V_{GS} = 10 \text{ V}$ (see Figure 15. Test circuit for inductive load switching and diode recovery times and Figure 18. Switching time waveform)	-	25	-	ns
$t_{r(\text{voff})}$	Off-voltage rise time		-	12	-	ns
$t_c$	Cross-over time		-	10	-	ns
			-	24	-	ns

Table 7. Source-drain diode

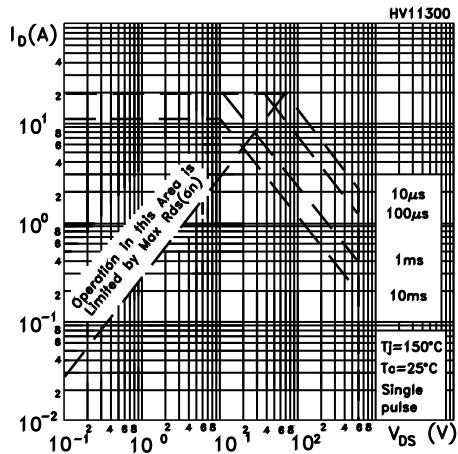
Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		5	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		20	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 5 \text{ A}, V_{GS} = 0 \text{ V}$	-		1.6	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 5 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}, V_{DD} = 30 \text{ V}$	-	485		ns
$Q_{rr}$	Reverse recovery charge	(see Figure 15. Test circuit for inductive load switching and diode recovery times)	-	2.7		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	11		A

1. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%.

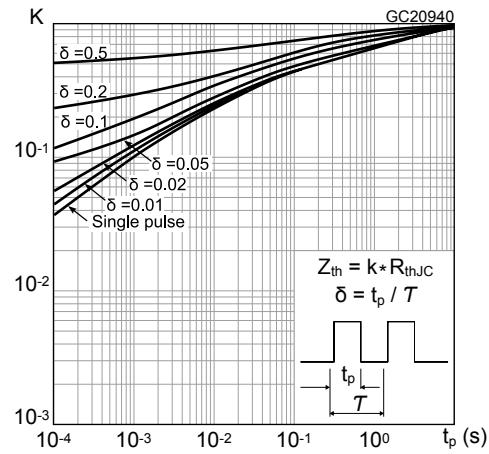
2. Pulse width is limited by safe operating area.

## 2.1 Electrical characteristics (curves)

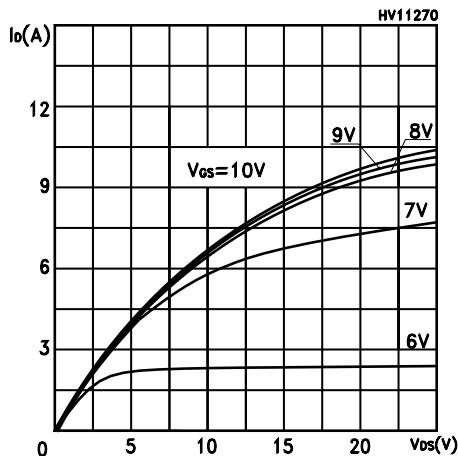
**Figure 1. Safe operating area**



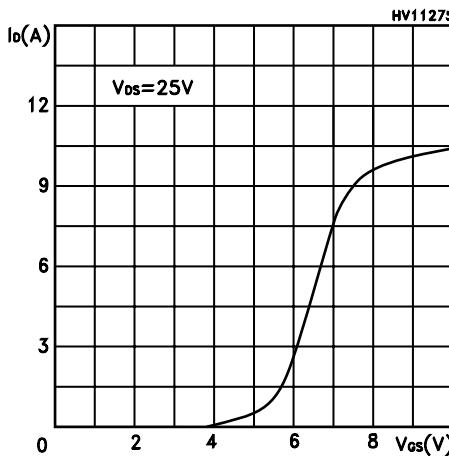
**Figure 2. Normalized transient thermal impedance**



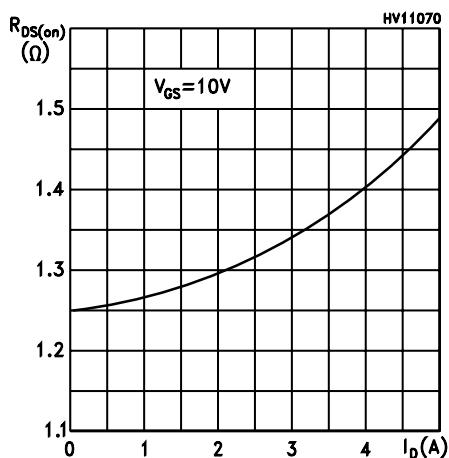
**Figure 3. Typical output characteristics**



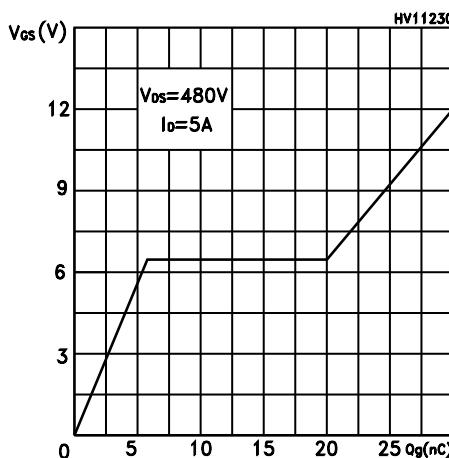
**Figure 4. Typical transfer characteristics**

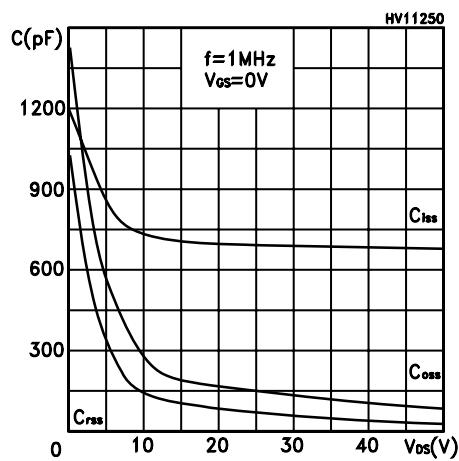
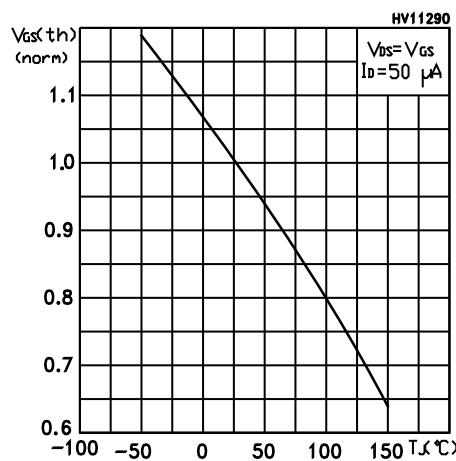
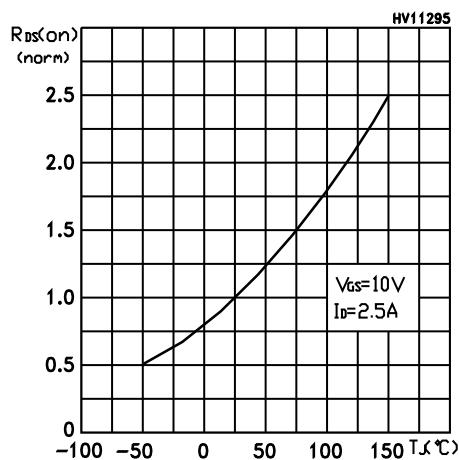
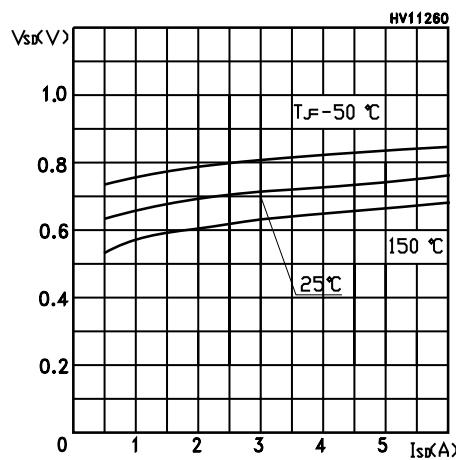
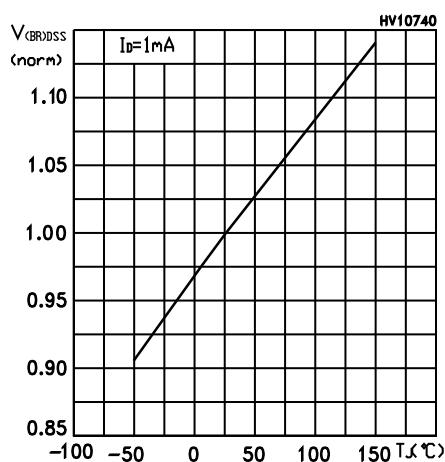
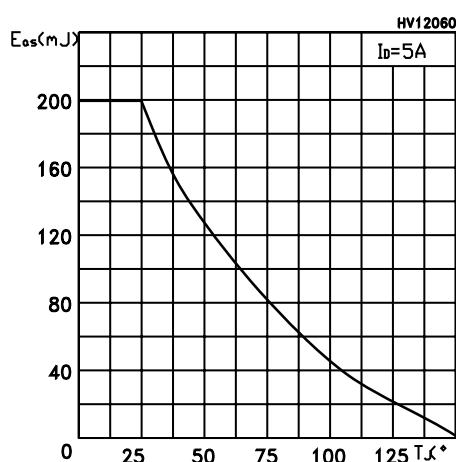


**Figure 5. Typical drain-source on-resistance**



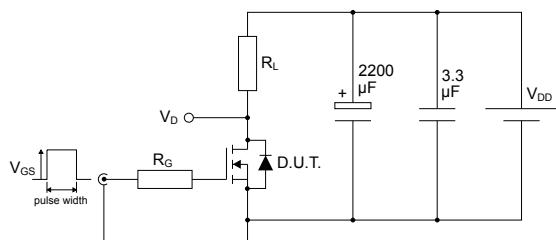
**Figure 6. Typical gate charge characteristics**



**Figure 7. Typical capacitance characteristics**

**Figure 8. Normalized gate threshold vs temperature**

**Figure 9. Normalized on-resistance vs temperature**

**Figure 10. Typical drain-source on-resistance**

**Figure 11. Normalized breakdown voltage vs temperature**

**Figure 12. Maximum avalanche energy vs temperature**


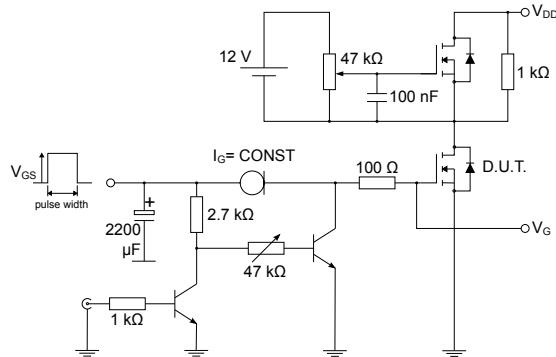
## 3 Test circuits

**Figure 13.** Test circuit for resistive load switching times



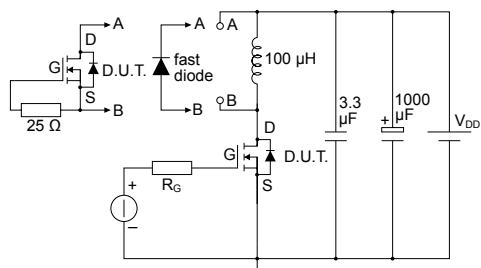
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**Figure 14.** Test circuit for gate charge behavior



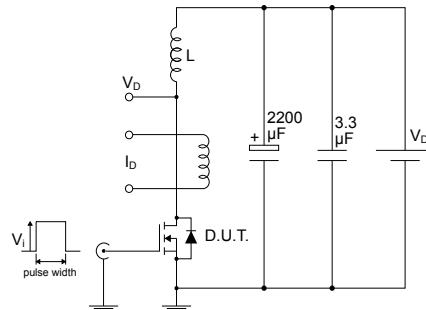
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**Figure 15.** Test circuit for inductive load switching and diode recovery times



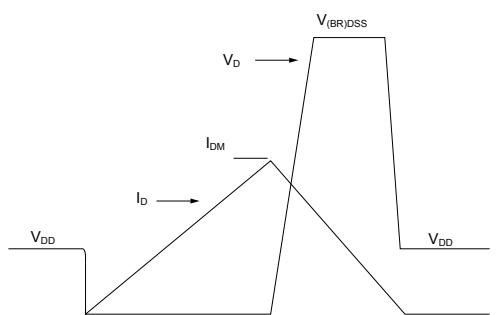
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**Figure 16.** Unclamped inductive load test circuit



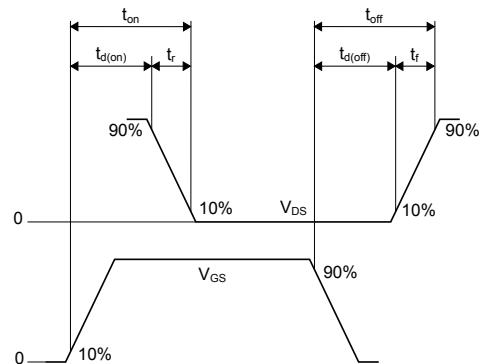
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**Figure 17.** Unclamped inductive waveform



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**Figure 18. Switching time waveform**



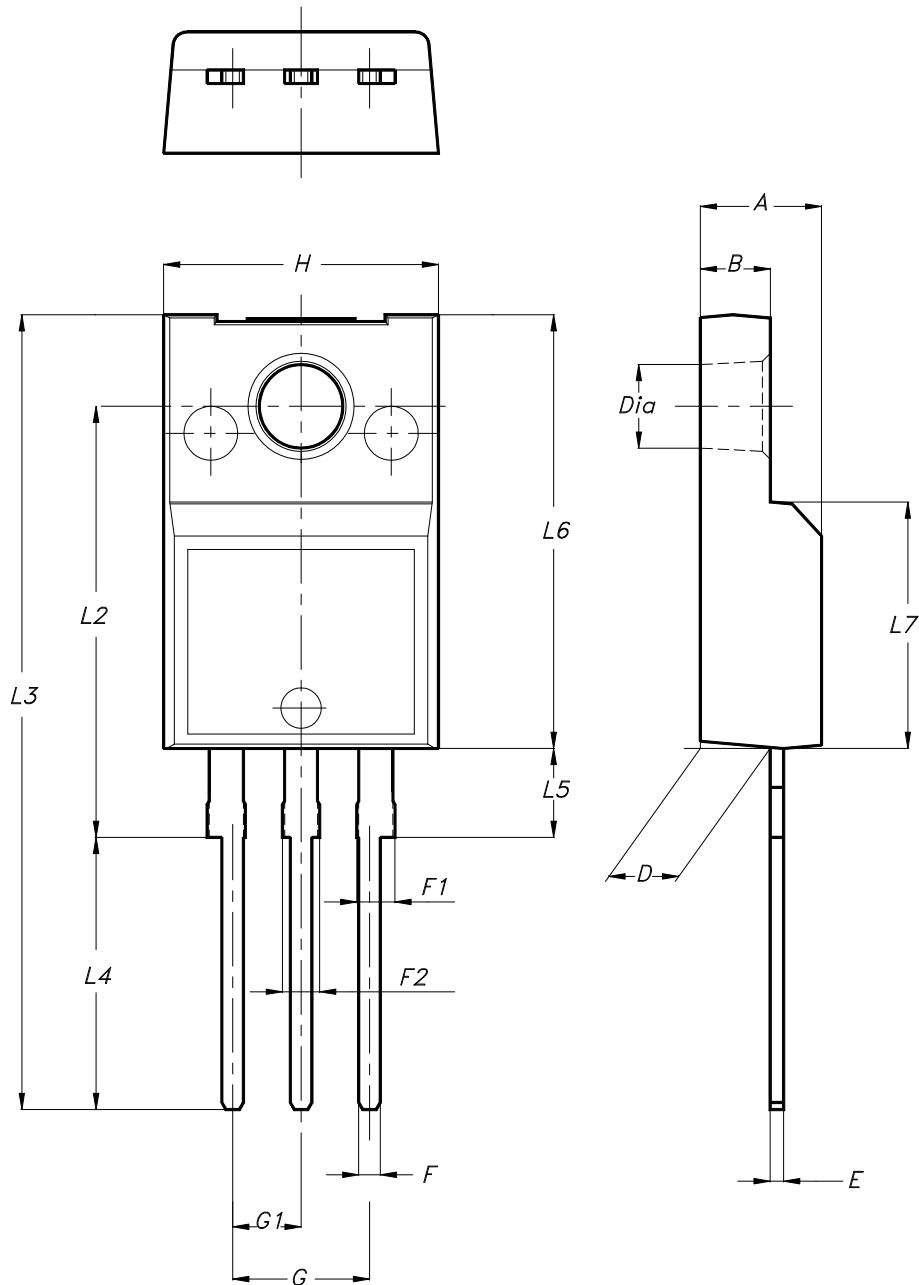
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## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

## 4.1 TO-220FP type B package information

Figure 19. TO-220FP type B package outline



7012510\_B\_rev.14

Table 8. TO-220FP type B package mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.40		4.60
B	2.50		2.70
D	2.50		2.75
E	0.45		0.70
F	0.75		1.00
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.20
G1	2.40		2.70
H	10.00		10.40
L2		16.00	
L3	28.60		30.60
L4	9.80		10.60
L5	2.90		3.60
L6	15.90		16.40
L7	9.00		9.30
Dia	3.00		3.20

## Revision history

**Table 9. Document revision history**

Date	Revision	Changes
25-Sep-2023	1	First release. Part number STP5NK60ZFP previously included in datasheet DS2857.

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